


<b>Search Notes</b>  	<b>Application/Control No.</b>  10567253	<b>Applicant(s)/Patent Under Reexamination</b>  TAKAI ET AL.
	<b>Examiner</b>  MEGAN ARNBERG	<b>Art Unit</b>  1796

SEARCHED			
Class	Subclass	Date	Examiner
525	524	2/28/2008	MCA
525	524	10/23/2008	MCM
525	524	4/23/2009	MCM

SEARCH NOTES		
Search Notes	Date	Examiner
Inventor name search -see printout	2/28/2008	MCA
EAST (US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT) - see printout	2/28/2008	MCA
Updated Inventor name search -see printout	10/23/2008	MCM
Updated EAST search -see printout	10/23/2008	MCM
Updated Inventor name search -see printout	4/23/2009	MCM
Updated EAST search -see printout	4/23/2009	MCM

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

/M. M./ Examiner.Art Unit 1796	
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